

Serial No.

Docket No.: RD-27,767-2

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of: Radislav Alexandrovich Potyrailo  
Serial No.:  
Filed:  
Group Art Unit:

For: **SYSTEMS AND METHODS FOR RAPID EVALUATION OF CHEMICAL RESISTANCE OF MATERIALS**

**INFORMATION DISCLOSURE STATEMENT**

Honorable Assistant Commissioner of Patents  
Washington, DC 20231

SIR:

This Information Disclosure Statement is being filed under 37 C.F.R. §1.56 for a continuing application, which relies on the filing date of its parent application, such parent application being identified as:

U.S. Patent Application Serial No.: 09/681,431

Examiner: Brian J. Sines

Filed: April 4, 2001

Allowed Date:

Inventor(s): Radislav Alexandrovich Potyrailo

Confirmation No:

Art Unit: 1743

Title: **SYSTEMS AND METHODS FOR RAPID EVALUATION OF CHEMICAL RESISTANCE OF MATERIALS**

Enclosed are copies of PTO-892 and PTO-1449 Forms listing all "prior art" cited and submitted in the parent application. Pursuant to 37 C.F.R. §1.98(d), no actual copies of the documents listed are being furnished to the PTO with this Information Disclosure Statement.

Respectfully submitted,

  
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DATE: March 16, 2004

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Form PTO-1449	U.S. Department of Commerce Patent & Trademark Office	Atty. Docket No.: RD-27,767	Serial No.: 09/681,431 Unassigned
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		Applicant(s): Radislav Potyrailo	
		Filing Date: 4/4/01 Herewith	Group: 1743 Unassigned

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			Applicant(s) <b>Potyrailo</b>				
			Filing Date <b>04/04/2001</b>	Group Art Unit <b>1743</b>			
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EXAMINER			DATE CONSIDERED				
<b>EXAMINER:</b> Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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		Examiner Brian J. Sines	Art Unit 1743	Page 1 of 1

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